# Power MOSFET, N-Channel, SUPERFET<sup>®</sup> III, FRFET<sup>®</sup>, 650 V, 65 A, 40 m $\Omega$

#### Description

SUPERFET III MOSFET is ON Semiconductor's brand-new high voltage super-junction (SJ) MOSFET family that is utilizing charge balance technology for outstanding low on-resistance and lower gate charge performance. This advanced technology is tailored to minimize conduction loss, provide superior switching performance, and withstand extreme dv/dt rate.

Consequently, SUPERFET III MOSFET is very suitable for the various power system for miniaturization and higher efficiency.

SUPERFET III FRFET MOSFET's optimized reverse recovery performance of body diode can remove additional component and improve system reliability.

#### Features

- 700 V @ T<sub>J</sub> = 150°C
- Typ.  $R_{DS(on)} = 33.8 \text{ m}\Omega$
- Ultra Low Gate Charge (Typ.  $Q_g = 153 \text{ nC}$ )
- Low Effective Output Capacitance (Typ. Coss(eff.) = 1333 pF)
- 100% Avalanche Tested
- AEC-Q101 Qualified and PPAP Capable

#### Applications

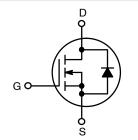
- Automotive On Board Charger HEV-EV
- Automotive DC/DC converter for HEV-EV



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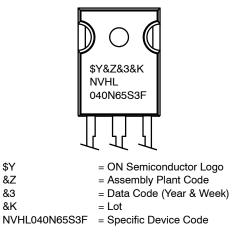
V <sub>DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
650 V	40 mΩ @ 10 V	65 A



**POWER MOSFET** 



#### MARKING DIAGRAM



#### **ORDERING INFORMATION**

See detailed ordering and shipping information on page 2 of this data sheet.

Symbol	Parame	NVHL040N65S3F	Unit V V	
V <sub>DSS</sub>	Drain to Source Voltage			650
V <sub>GSS</sub>	Gate to Source Voltage - DC			±30
		– AC (f > 1 Hz)	±30	
I <sub>D</sub>	Drain Current	– Continuous (T <sub>C</sub> = 25°C)	65	А
		– Continuous (T <sub>C</sub> = 100°C)	45	
I <sub>DM</sub>	Drain Current	- Pulsed (Note 1)	162.5	А
E <sub>AS</sub>	Single Pulsed Avalanche Energy (Note 2)		1009	mJ
E <sub>AR</sub>	Repetitive Avalanche Energy (Note 1)		4.46	mJ
dv/dt	MOSFET dv/dt Peak Diode Recovery dv/dt (Note 3)		100	V/ns
			50	
P <sub>D</sub>	Power Dissipation	(T <sub>C</sub> = 25°C)	446	W
		– Derate Above 25°C	3.57	W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range		–55 to +150	°C
ΤL	Maximum Lead Temperature for Soldering, 1/8" from Case for 5 seconds		300	°C

#### **ABSOLUTE MAXIMUM RATINGS** (T<sub>C</sub> = 25°C, Unless otherwise noted)

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected. 1. Repetitive rating: pulse-width limited by maximum junction temperature. 2.  $I_{AS} = 9 \text{ A}$ ,  $R_G = 25 \Omega$ , starting  $T_J = 25^{\circ}C$ . 3.  $I_{SD} \leq 32.5 \text{ A}$ , di/dt  $\leq 200 \text{ A}/\mu\text{s}$ ,  $V_{DD} \leq 400 \text{ V}$ , starting  $T_J = 25^{\circ}C$ .

#### THERMAL CHARACTERISTICS

Symbol	Parameter	NVHL040N65S3F	Unit
$R_{\theta JC}$	Thermal Resistance, Junction to Case, Max.	0.28	°C/W
R <sub>0JA</sub>	Thermal Resistance, Junction to Ambient, Max.	40	

#### PACKAGE MARKING AND ORDERING INFORMATION

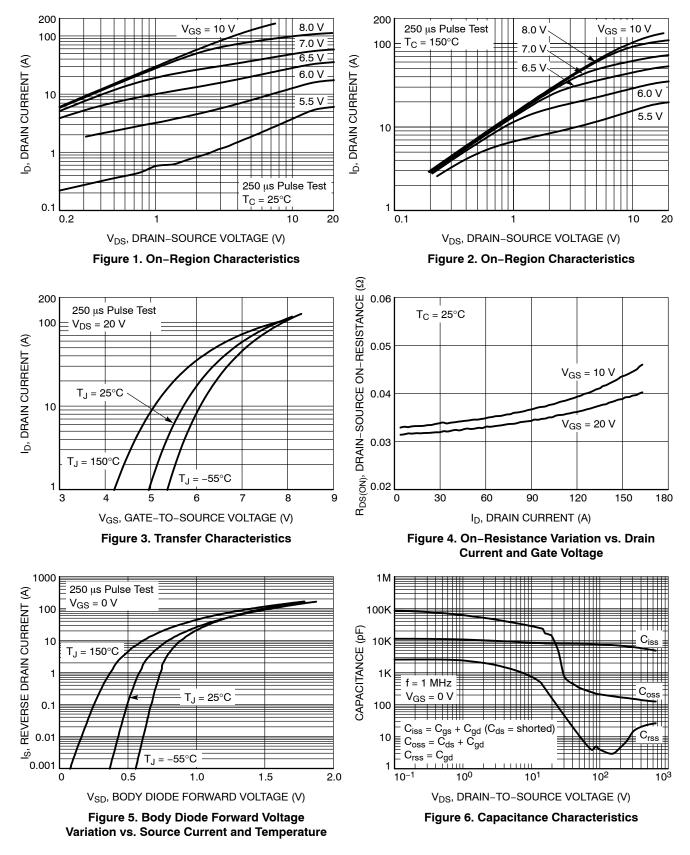
Part Number	Top Marking	Package	Packing Method	Reel Size	Tape Width	Quantity
NVHL040N65S3F	NVHL040N65S3F	TO-247	Tube	N/A	N/A	30 Units

#### ELECTRICAL CHARACTERISTICS (T<sub>C</sub> = 25°C unless otherwise noted)

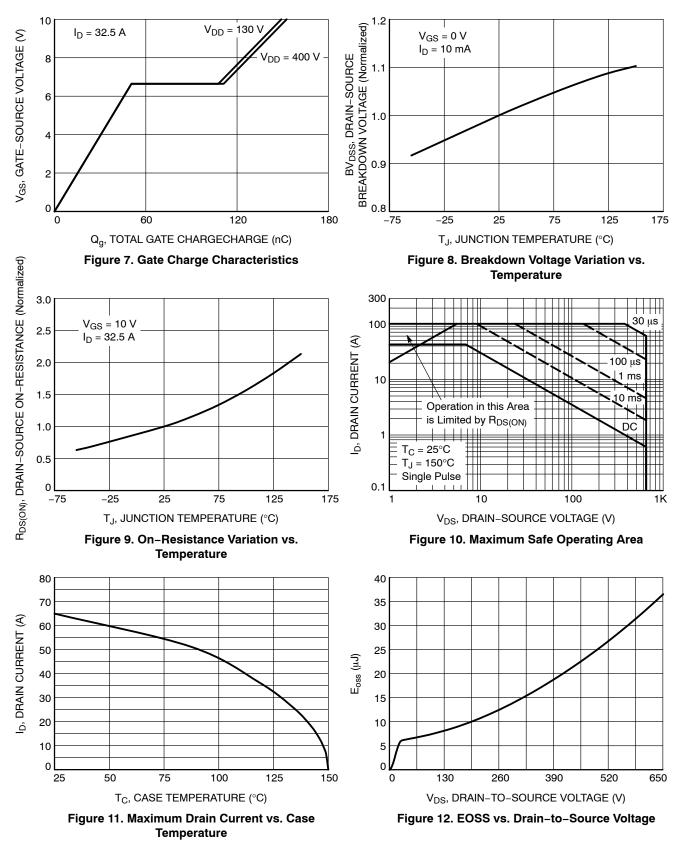
Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
OFF CHARACT	ERISTICS	••			•	
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, \text{ I}_{D} = 1 \text{ mA}, \text{ T}_{J} = 25^{\circ}\text{C}$	650	-	-	V
		$V_{GS}$ = 0 V, $I_{D}$ = 10 mA, $T_{J}$ = 150°C	700	-	-	V
$\Delta \text{BV}_{\text{DSS}}  /  \Delta \text{T}_{\text{J}}$	Breakdown Voltage Temperature Coefficient	$I_D$ = 10 mA, Referenced to 25°C	-	0.64	-	V/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = 650 \text{ V}, V_{GS} = 0 \text{ V}$	-	-	10	μA
		$V_{DS}$ = 520 V, $T_{C}$ = 125°C	-	103	-	
I <sub>GSS</sub>	Gate to Body Leakage Current	$V_{GS}=\pm30~\text{V},~V_{DS}=0~\text{V}$	-	-	±100	nA
ON CHARACTE	RISTICS	••				
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{GS} = V_{DS}$ , $I_D = 2.1$ mA	3.0	-	5.0	V
R <sub>DS(on)</sub>	Static Drain to Source On Resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 32.5 A	-	33.8	40	mΩ
9 <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> = 20 V, I <sub>D</sub> = 32.5 A	-	40	-	S
DYNAMIC CHAI	RACTERISTICS			•		
C <sub>iss</sub>	Input Capacitance	$V_{DS}$ = 400 V, $V_{GS}$ = 0 V, f = 1 MHz	-	5875	-	pF
C <sub>oss</sub>	Output Capacitance		-	140	-	pF
C <sub>oss(eff.)</sub>	Effective Output Capacitance	$V_{DS}$ = 0 V to 400 V, $V_{GS}$ = 0 V	-	1333	-	pF
C <sub>oss(er.)</sub>	Energy Related Output Capacitance	$V_{DS}$ = 0 V to 400 V, $V_{GS}$ = 0 V	-	241	-	pF
Q <sub>g(tot)</sub>	Total Gate Charge at 10 V	$V_{DS} = 400 \text{ V}, \text{ I}_{D} = 32.5 \text{ A}, \text{ V}_{GS} = 10 \text{ V}$	-	153	-	nC
Q <sub>gs</sub>	Gate to Source Gate Charge	(Note 4)	-	51	-	nC
Q <sub>gd</sub>	Gate to Drain "Miller" Charge		-	61	-	nC
ESR	Equivalent Series Resistance	f = 1 MHz	-	1.9	-	Ω
SWITCHING CH	IARACTERISTICS	•			•	
t <sub>d(on)</sub>	Turn-On Delay Time	$V_{DD}$ = 400 V, I <sub>D</sub> = 32.5 A, V <sub>GS</sub> = 10 V	-	41	-	ns
t <sub>r</sub>	Turn-On Rise Time	R <sub>g</sub> = 2.2 Ω (Note 4)	-	53	-	ns
t <sub>d(off)</sub>	Turn-Off Delay Time		-	96	-	ns
t <sub>f</sub>	Turn-Off Fall Time		-	28	-	ns
SOURCE-DRAII	N DIODE CHARACTERISTICS				•	
I <sub>S</sub>	Maximum Continuous Source to Drain Diode Forward Current			-	65	А
I <sub>SM</sub>	Maximum Pulsed Source to Drain Diode Forward Current		-	-	162.5	А
V <sub>SD</sub>	Source to Drain Diode Forward Voltage	V <sub>GS</sub> = 0 V, I <sub>SD</sub> = 32.5 A	-	-	1.3	V
t <sub>rr</sub>	Reverse Recovery Time	$V_{GS} = 0 V, I_{SD} = 32.5 A,$	-	159	-	ns
Q <sub>rr</sub>	Reverse Recovery Charge	dI <sub>F</sub> /dt = 100 A/µs	-	840	-	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 4. Essentially independent of operating temperature typical characteristics.

#### **TYPICAL CHARACTERISTICS**



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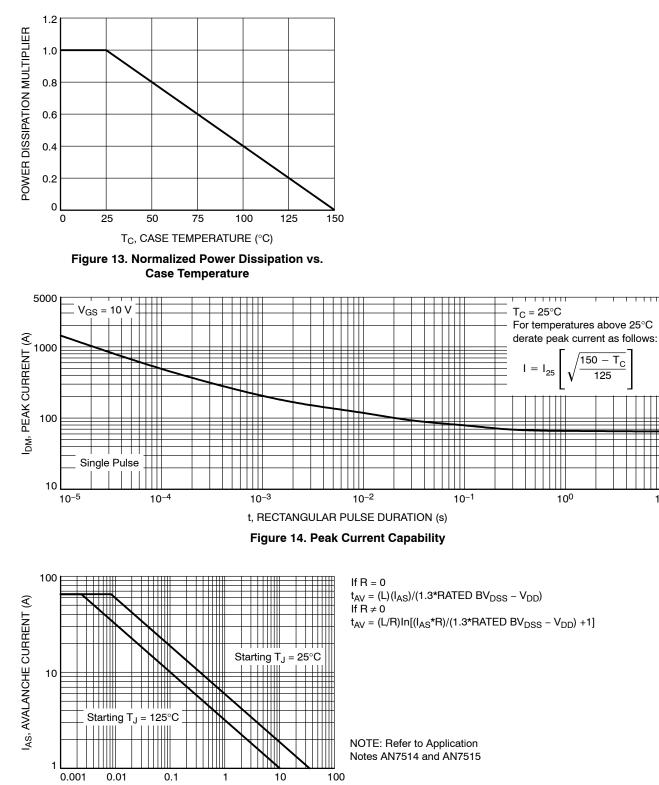


#### **TYPICAL CHARACTERISTICS**

150 – T<sub>C</sub>

125

10<sup>1</sup>





#### **TYPICAL CHARACTERISTICS**

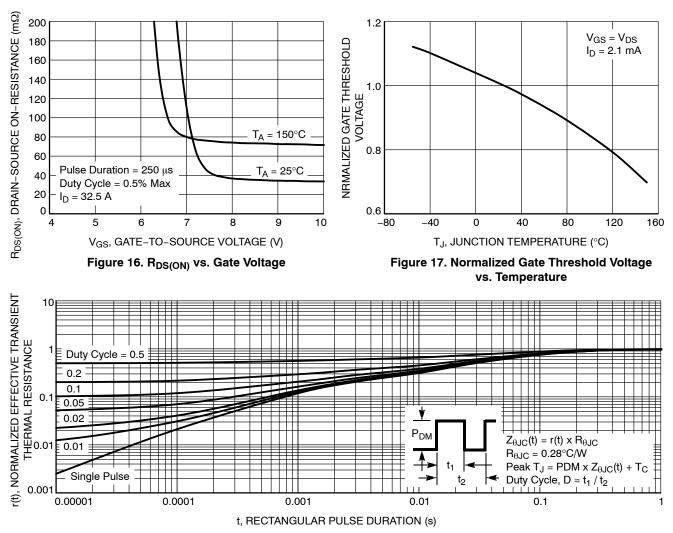
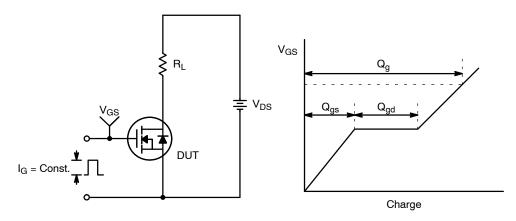


Figure 18. Transient Thermal Response Curve





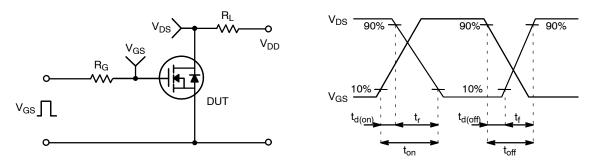
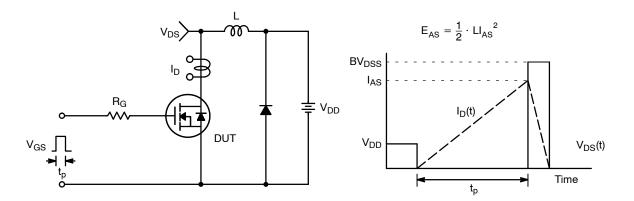


Figure 20. Resistive Switching Test Circuit & Waveforms





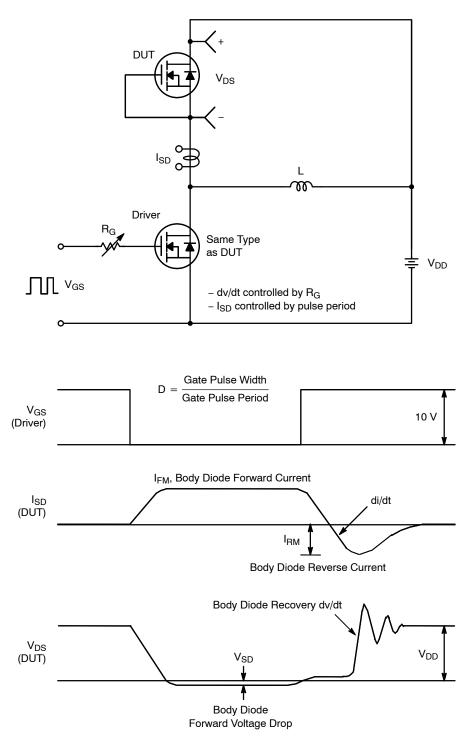
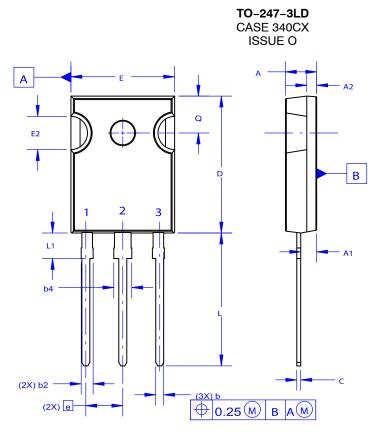


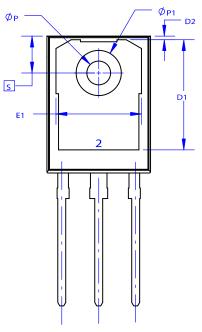
Figure 22. Peak Diode Recovery dv/dt Test Circuit & Waveforms

#### **PACKAGE DIMENSIONS**



NOTES: UNLESS OTHERWISE SPECIFIED.

- A. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS.
- B. ALL DIMENSIONS ARE IN MILLIMETERS.
- C. DRAWING CONFORMS TO ASME Y14.5 2009.
  D. DIMENSION A1 TO BE MEASURED IN THE REGION DEFINED BY L1.
- E. LEAD FINISH IS UNCONTROLLED IN THE REGION DEFINED BY L1.



	MILLIMETERS				
DIM	MIN	NOM	MAX		
Α	4.58	4.70	4.82		
A1	2.20	2.40	2.60		
A2	1.40	1.50	1.60		
D	20.32	20.57	20.82		
E	15.37	15.62	15.87		
E2	4.96	5.08	5.20		
е	~	5.56	~		
L	19.75	20.00	20.25		
L1	3.69	3.81	3.93		
ØР	3.51	3.58	3.65		
Q	5.34	5.46	5.58		
S	5.34	5.46	5.58		
b	1.17	1.26	1.35		
b2	1.53	1.65	1.77		
b4	2.42	2.54	2.66		
С	0.51	0.61	0.71		
D1	13.08	~	~		
D2	0.51	0.93	1.35		
E1	12.81	~	~		
Ø <b>P</b> 1	6.60	6.80	7.00		

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